

<b>Notice of References Cited</b>	Application/Control No. 10/664,264		Applicant(s)/Patent Under Reexamination WERTENBRUCH ET AL.	
	Examiner Ellen C. Tran		Art Unit 2134	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,351,773 B1	02-2002	Fijolek et al.	709/228
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

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